TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC7MZ244FK

Low Voltage Octal Bus Buffer with 5 V Tolerant Inputs and Outputs

The TC7MZ244FK is a high performance CMOS octal bus buffer. Designed for use in 3.3 V systems, it achieves high speed operation while maintaining the CMOS low power dissipation.

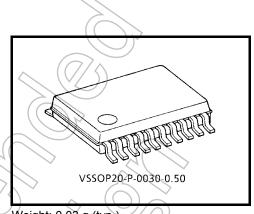
The device is designed for low-voltage (3.3 V) VCC applications, but it could be used to interface to 5 V supply environment for both inputs and outputs.

The TC7MZ244FK is a non-inverting 3-state buffer having two active-low output enables. This device is designed to be used with 3-state memory address drivers, etc.

All inputs are equipped with protection circuits against static discharge.

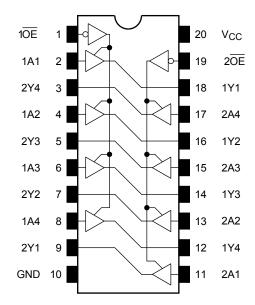
Features

- Low voltage operation: $V_{CC} = 2.0 \sim 3.6 \text{ V}$
- High speed operation: $t_{pd} = 6.5 \text{ ns} (\text{max}) (V_{CC} = 3.0 \sim 3.6 \text{ V})$
- Output current: $|I_{OH}|/I_{OL} = 24 \text{ mA} (\text{min}) (V_{CC} = 3.0 \text{ V})$
- Latch-up performance: -500 mA
- Package: VSSOP (US20)
- Power down protection is provided on all inputs and outputs.
- Pin and function compatible with the 74 series (74AC/VHC/HC/F/ALS/LS etc.) 244 type.



Weight: 0.03 g (typ.)

Pin Assignment (top view)



Truth Table

	Outputs	Inputs					
	Outputs	An	ŌĒ				
_	L	L	L				
2	Н	Н	L				
	Z	Х	Н				

X: Don't care

Z: High impedance

Absolute Maximum Ratings (Note 1)

Characteristics	cteristics Symbol Rating		Unit
Supply voltage range	Vcc <	-0.5~7.0	V
DC input voltage	VIN	-0.5~7.0	V
DC output voltage	Vour	-0.5~7.0 (Note 2)	V
	V _{OUT}	–0.5~V _{CC} + 0.5 (Note 3)	v
Input diode current	ιĸ	-50	mA
Output diode current	Јок	±50 (Note 4)	mA
DC output current	IOUT	±50	mA
Power dissipation	PD	180	mW
DC V _{CC} /ground current	ICC/IGND	±100	mA
Storage temperature	T _{stg}	-65~150	°C

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

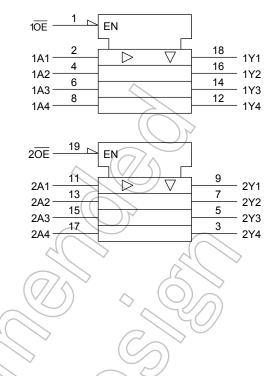
Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2: Output in off-state

- Note 3: High or low state. IOUT absolute maximum rating must be observed.
- Note 4: $V_{OUT} < GND, V_{OUT} > V_{CC}$

IEC Logic Symbol



Operating Ranges (Note 1)

Characteristics	Symbol	Rating	Unit	
O mark was the sec	Vee	2.0~3.6	V	
Supply voltage	V _{CC}	1.5~3.6 (Note 2)		
Input voltage	V _{IN}	0~5.5	V	
Output voltage	V _{OUT}	0~5.5 (Note 3)	V	$\langle \rangle$
Output voltage	V001	0~V _{CC} (Note 4)	v	
Output current	IOH/IOL	±24 (Note 5)	mA	7
output current	'OH''OL	±12 (Note 6)		$\bigcirc)$
Operating temperature	T _{opr}	-40~85	°C	
Input rise and fall time	dt/dv	0~10 (Note 7)	ns/V	/

Note 1: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either VCC or GND.

Note 2: Data retention only

- Note 3: Output in off-state
- Note 4: High or low state
- Note 5: $V_{CC} = 3.0 \sim 3.6 \text{ V}$
- Note 6: $V_{CC} = 2.7 \sim 3.0 \text{ V}$
- Note 7: $V_{IN}=0.8{\sim}2.0$ V, $V_{CC}=3.0$ V

Electrical Characteristics

DC Characteristics (Ta = -40~85°C)

Characte	ristics	Symbol	Test	Condition	V _{CC} (V)	Min	Max	Unit
Input voltage	High level	VIH	\mathcal{I}		2.7~3.6	2.0	_	V
Input voltage	Low level	VIL		())	2.7~3.6	_	0.8	v
				I _{OH} = -100 μA	2.7~3.6	V _{CC} - 0.2		
	High level	VOH	$V_{IN} = V_{IH} \text{ or } V_{IL}$	I _{OH} = -12 mA	2.7	2.2		
	Z J		\sim	I _{OH} = -18 mA	3.0	2.4		
Output voltage			$\mathcal{A}($	I _{OH} = -24 mA	3.0	2.2		V
\sim (($I_{OL} = 100 \ \mu A$ $I_{OL} = 12 \ m A$	I _{OL} = 100 μA	2.7~3.6	_	0.2	
	Low level			I _{OL} = 12 mA	2.7	_	0.4	
				I _{OL} = 16 mA	3.0	_	0.4	
				I _{OL} = 24 mA	3.0	_	0.55	
Input leakage cur	rrent	I _{IN}	V _{IN} = 0~5.5 V		2.7~3.6	—	±5.0	μA
3 state output off	stato curront	107	$V_{IN} = V_{IH} \text{ or } V_{IL}$		2.7~3.6	_	±5.0	μA
5-state output on	3-state output off-state current I _{OZ}		V _{OUT} = 0~5.5 V		2.7~5.0	_	±5.0	μA
Power off leakage	e current	I _{OFF}	V _{IN} /V _{OUT} = 5.5 V		0	—	10.0	μA
	ourropt	laa	$V_{IN} = V_{CC} \text{ or } GND$		2.7~3.6	_	10.0	
Quiescent supply current		ICC	V _{IN} /V _{OUT} = 3.6~5.5 V		2.7~3.6	_	±10.0	μA
Increase in I _{CC} p	er input	ΔI_{CC}	$V_{IH} = V_{CC} - 0.6 V$		2.7~3.6	_	500	

AC Characteristics (Ta = -40~85°C)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Min	Max	Unit
Propagation delay time	t _{pLH}	Figure 1, Figure 2	2.7		7.5	ns
	t _{pHL}		$\textbf{3.3}\pm\textbf{0.3}$	1.5	6.5	113
Output enable time	t _{pZL}	Figure 1 Figure 2	2.7		9.0	ns
	t _{pZH}	Figure 1, Figure 3	3.3 ± 0.3	1.5	8.0	115
Output disable time tpLZ tpHZ Figure 1, Figure 3	Eiguro 1 Eiguro 3	2.7	ワー	8.0	ns	
	t _{pHZ}		3.3 ± 0.3	1.5	7.0	115
Output to output skew	t _{osLH}	(Note)	2.1			200
	t _{osHL}	(NOLE)	3.3 ± 0.3	_	1.0	ns

Note: This parameter is guaranteed by design.

 $(t_{OSLH} = |t_{pLHm} - t_{pLHn}|, t_{OSHL} = |t_{pHLm} - t_{pHLn}|)$

Dynamic Switching Characteristics

$(Ta = 25^{\circ}C, Input: t_r = t_f = 2.5 \text{ ns}, C_L = 50 \text{ pF}, R_L = 500 \Omega)$

Characteristics	Symbol	Test Condition	V _{CC} (V)	Тур.	Unit
Quiet output maximum dynamic V_{OL}	V _{OLP}	V _{IH} = 3.3 V, V _{IL} = 0 V	3.3	0.8	V
Quiet output minimum dynamic VOL	V _{OLV}	V _{IH} = 3.3 V, V _{IL} = 0 V	3.3	0.8	V

Capacitive Characteristics (Ta = $25^{\circ}C$)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Тур.	Unit
Input capacitance	CIN		3.3	7	pF
Output capacitance	Cout		3.3	8	pF
Power dissipation capacitance	CPD	f _{IN} = 10 MHz (Note)	3.3	25	pF

Note: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/8 (per bit)$

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AC Test Circuit

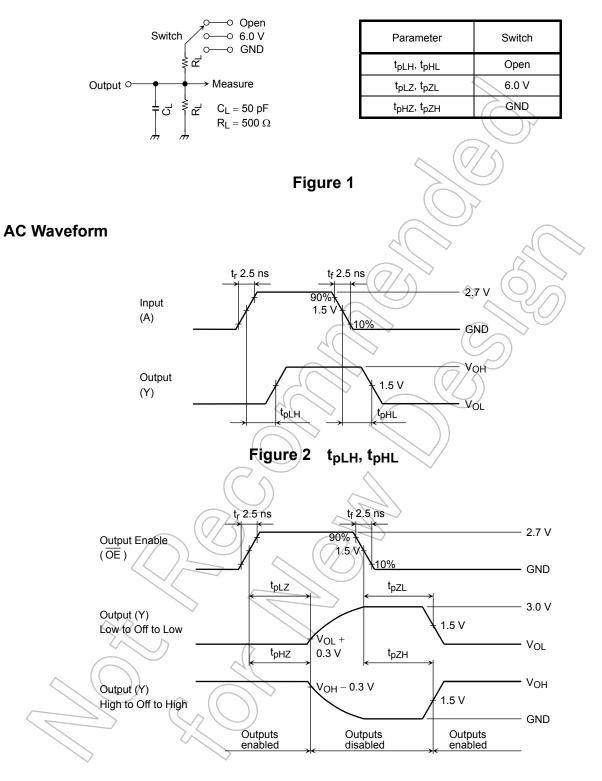
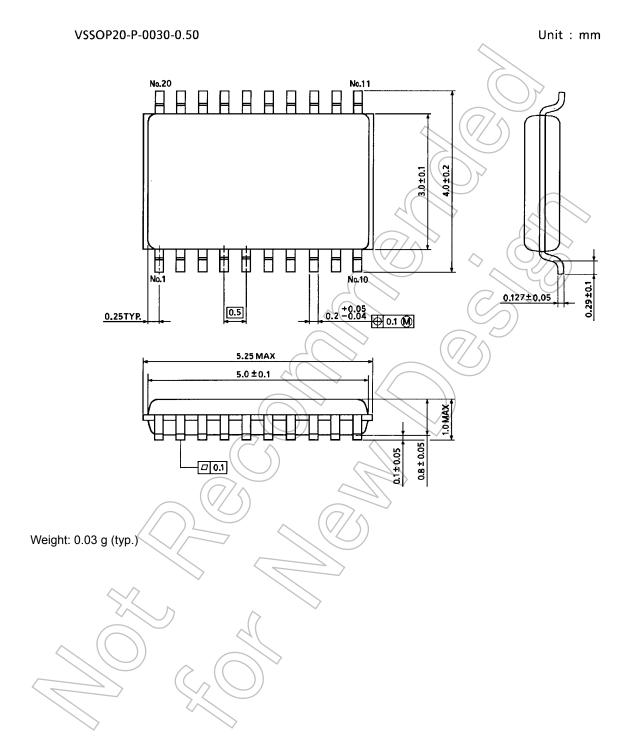


Figure 3 t_{pLZ} , t_{pHZ} , t_{pZL} , t_{pZH}

Package Dimensions



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